

Search Notes



Application/Control No.

10/813,129

Examiner

Hiep Nguyen

Applicant(s)/Patent under
Reexamination

HIRAMATSU ET AL.

Art Unit

2816

SEARCHED

Class	Subclass	Date	Examiner
327	143	04.26.05	Nh
	198	T	T
	63		
	68		
	72		
	538	↓	↓
	77	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
327	143	04.26.05	Nh
	198		
	63		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST See attachment	04.18.05	Nh
EAST See attachment	05.12.05	Nh